

### FEATURES

- Qualification in Accordance With AEC-Q100 (1)
- Qualified for Automotive Applications
- Customer-Specific Configuration Control Can Be Supported Along With Major-Change Approval
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Operates From 2 V to 3.6 V
- Inputs Accept Voltages to 5.5 V
- Max t<sub>nd</sub> of 7 ns at 3.3 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)
  <0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)
  >2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Supports Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V V<sub>CC</sub>)
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- (1) Contact factory for details. Q100 qualification data available on request.

### **DESCRIPTION/ORDERING INFORMATION**

The SN74LVCH245A octal bus transceiver is designed for 2.7-V to 3.6-V  $V_{CC}$  operation.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of this device as a translator in a mixed 3.3-V/5-V system environment.

This device is designed for asynchronous communication between data buses. The device transmits data from the A bus to the B bus or from the B bus to the A bus, depending on the logic level at the direction-control (DIR) input. The output-enable  $(\overline{OE})$  input can be used to disable the device so the buses are effectively isolated.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended. The bus-hold circuitry is part of the input circuit and is not disabled by  $\overline{\text{OE}}$  or DIR.

This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

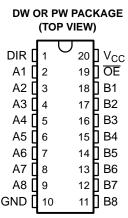
T <sub>A</sub>	PACKAGE <sup>(1)</sup>		PACKAGE <sup>(1)</sup> ORDERABLE PART NUMBER	
40°C to 125°C	SOIC – DW	Reel of 2000	SN74LVCH245AQDWRQ1	LH245AQ
–40°C to 125°C	TSSOP – PW	Reel of 2000	SN74LVCH245AQPWRQ1	LH245AQ

#### **ORDERING INFORMATION**

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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# SN74LVCH245A-Q1 **OCTAL BUS TRANSCEIVER** WITH 3-STATE OUTPUTS

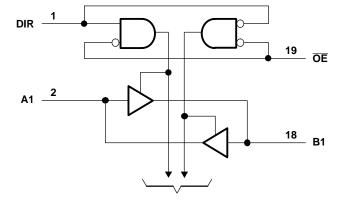
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### **FUNCTION TABLE**

INP	UTS	OPERATION
OE	DIR	OPERATION
L	L	B data to A bus
L	н	A data to B bus
н	Х	Isolation

### LOGIC DIAGRAM (POSITIVE LOGIC)



**To Seven Other Channels** 

### Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range			6.5	V
VI	Input voltage range <sup>(2)</sup>		-0.5	6.5	V
Vo	Voltage range applied to any output in the high-imped	dance or power-off state <sup>(2)</sup>	-0.5	6.5	V
Vo	$V_{O}$ Voltage range applied to any output in the high or low state <sup>(2)(3)</sup>			V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
I <sub>O</sub>	Continuous output current			±50	mA
	Continuous current through V <sub>CC</sub> or GND			±100	mA
0		DW package		58	
$\theta_{JA}$	Package thermal impedance <sup>(4)</sup>	PW package		83	°C/W
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
 (3) The value of V<sub>CC</sub> is provided in the recommended operating conditions table.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

## **Recommended Operating Conditions**<sup>(1)</sup>

			MIN	MAX	UNIT
V	Supply veltage	Operating	2	3.6	V
V <sub>CC</sub>	Supply voltage	Data retention only	1.5		v
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 2.7 V to 3.6 V	2		V
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 2.7 V to 3.6 V		0.8	V
VI	Input voltage		0	5.5	V
	Output voltage	High or low state	0		V
Vo	Output voltage	3-state	0	5.5	v
	Lich lovel output ourrest	V <sub>CC</sub> = 2.7 V		-12	~ ^
I <sub>OH</sub>	High-level output current	$V_{CC} = 3 V$		-24	mA
	I and be all and and an investig	V <sub>CC</sub> = 2.7 V		12	
I <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 3 V		24	mA
$\Delta t/\Delta v$	Input transition rise or fall rate			10	ns/V
T <sub>A</sub>	Operating free-air temperature		-40	125	°C

All unused control inputs of the device must be held at  $V_{CC}$  or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004. (1)

### **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

PA	ARAMETER	TEST CONDITION	NS	V <sub>cc</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT
		I <sub>OH</sub> = -100 μA	2.7 V to 3.6 V	$V_{CC} - 0.2$				
		40 40		2.7 V	2.2			
V <sub>OH</sub>		$I_{OH} = -12 \text{ mA}$		3 V	2.4			V
		I <sub>OH</sub> = -24 mA		3 V	2.2			
		I <sub>OL</sub> = 100 μA		2.7 V to 3.6 V			0.2	
V <sub>OL</sub>		I <sub>OL</sub> = 12 mA	2.7 V			0.4	V	
		I <sub>OL</sub> = 24 mA	3 V			0.55		
I <sub>I</sub>	Control inputs	V <sub>1</sub> = 0 to 5.5 V		3.6 V			±5	μΑ
		V <sub>1</sub> = 0.8 V V <sub>1</sub> = 2 V		- 3 V -	75			
I <sub>I(hold)</sub>					-75			μA
		$V_{\rm I} = 0$ to 3.6 V <sup>(2)</sup>		3.6 V			±500	
$I_{OZ}^{(3)}$		$V_{O} = 0 V \text{ or } (V_{CC} \text{ to } 5.5 V)$		2.3 V to 3.6 V			±15	μΑ
		$V_{I} = V_{CC}$ or GND		0.01/			10	
Icc		$3.6 \text{ V} \le \text{V}_1 \le 5.5 \text{ V}^{(4)}$	$I_0 = 0$	3.6 V			10	μA
$\Delta I_{CC}$		One input at $V_{CC}$ – 0.6 V, Other inputs at $V_{CC}$ or GND		2.7 V to 3.6 V			500	μΑ
Ci	Control inputs	$V_{I} = V_{CC}$ or GND		3.3 V		4	12	pF
Cio	A or B port	$V_{O} = V_{CC}$ or GND		3.3 V		5.5	12	pF

All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C. (1)

(2)

This is the bus-hold maximum dynamic current required to switch the input from one state to another. For the total leakage current in an I/O port, consult the  $I_{I(hold)}$  specification for the input voltage condition 0 V <  $V_I$  <  $V_{CC}$ , and the  $I_{OZ}$  specification for the input voltage conditions  $V_I = 0$  V or  $V_I = V_{CC}$  to 5.5 V. The bus-hold current, at input voltage greater than  $V_{CC}$ , is (3) negligible.

This applies in the disabled state only. (4)

# SN74LVCH245A-Q1 OCTAL BUS TRANSCEIVER WITH 3-STATE OUTPUTS

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### **Switching Characteristics**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 2.7 V	$V_{CC} = 3.3 V \\ \pm 0.3 V$		UNIT
	(INFOT)	(001F01)	MIN MAX	MIN	MAX	
t <sub>pd</sub>	A or B	B or A	8	1	7	ns
t <sub>en</sub>	ŌĒ	A or B	9.5	1	8.5	ns
t <sub>dis</sub>	ŌĒ	A or B	8.5	1	7.5	ns

## **Operating Characteristics**

 $T_A = 25^{\circ}C$ 

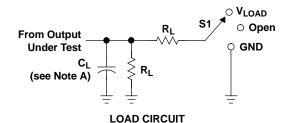
PARAMETER			TEST CONDITIONS	V <sub>CC</sub> = 2.5 V TYP	V <sub>CC</sub> = 3.3 V TYP	UNIT	
C	Dower dissinction consolitance per transceiver	Outputs enabled	f = 10 MHz	(1)	47	рF	
C <sub>pd</sub>	Power dissipation capacitance per transceiver	Outputs disabled		(1)	2	рн	

(1) This information was not available at the time of publication.

# SN74LVCH245A-Q1 OCTAL BUS TRANSCEIVER WITH 3-STATE OUTPUTS

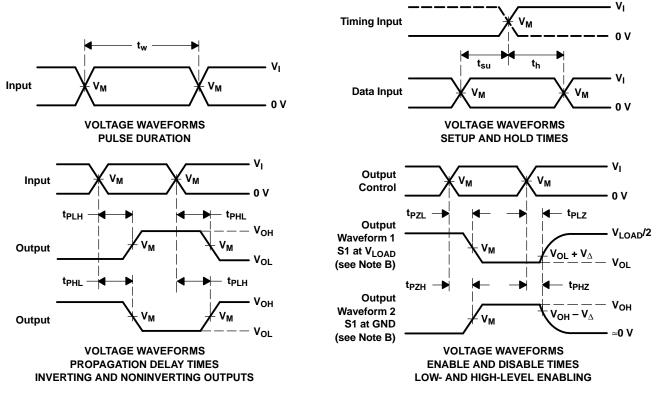
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### PARAMETER MEASUREMENT INFORMATION



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

	INPUTS					-		
V <sub>CC</sub>	vı	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	CL	RL	$V_{\Delta}$	
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V	
3.3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V	



- NOTES: A.  $C_L$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z\_0 = 50  $\Omega$ .
  - D. The outputs are measured one at a time, with one transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
  - H. All parameters and waveforms are not applicable to all devices.

### Figure 1. Load Circuit and Voltage Waveforms

### PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74LVCH245AQDWRQ1	OBSOLETE	SOIC	DW	20	TBD	Call TI	Call TI
SN74LVCH245AQPWRQ1	OBSOLETE	TSSOP	PW	20	TBD	Call TI	Call TI

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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#### OTHER QUALIFIED VERSIONS OF SN74LVCH245A-Q1 :

- Catalog: SN74LVCH245A
- Military: SN54LVCH245A

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

DW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AC.



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.  $\beta$ . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



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